

EAST Search History

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|-----|------|---|---|----|-----|------------------|
| S2 | 2190 | "257"/\$.ccls. and (dummy) same (gate) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/04/29 15:45 |
| S3 | 1815 | "257"/\$.ccls. and (dummy) with (gate) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/04/29 16:54 |
| S4 | 131 | "257"/\$.ccls. and (dummy) with (gate) with silicide | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/04/30 13:42 |
| S5 | 267 | (gate adj.electrode) with (aluminum adj oxide) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/04/30 14:12 |
| S6 | 160 | (gate adj electrode) with (aluminum adj oxide) | USPAT | OR | OFF | 2005/04/30 13:45 |
| S7 | 2 | (gate adj electrode) with (aluminum adj oxide) with advantag\$4 | USPAT | OR | OFF | 2006/04/08 16:35 |
| S8 | 156 | (gate) with (nickel near silicide) | USPAT | OR | OFF | 2005/04/30 13:47 |
| S9 | 8 | (gate) with (germanium near silicide) | USPAT | OR | OFF | 2005/04/30 13:49 |
| S10 | 672 | semiconductor-on-insulator | USPAT | OR | OFF | 2005/04/30 13:50 |
| S11 | 7 | semiconductor-on-insulator with advantag\$4 and memory | USPAT | OR | OFF | 2005/04/30 13:55 |
| S12 | 2 | semiconductor-on-insulator with advantag\$4 and DRAM | USPAT | OR | OFF | 2005/04/30 13:53 |

EAST Search History

| Ref # | Hits | Search Query | DBs | Default Operator | Plurals | Time Stamp |
|-------|------|--|---|------------------|---------|------------------|
| L1 | 2 | (dummy near3 gate) and souce and drain | USPAT | OR | OFF | 2006/04/08 16:36 |
| L2 | 2 | (dummy near3 gate) and souce and drain | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | OFF | 2006/04/08 16:44 |
| L3 | 2528 | (dummy near3 gate) and source and drain | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | OFF | 2006/04/08 16:45 |
| L4 | 185 | (dummy near3 gate with silici\$4) and source and drain | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | OFF | 2006/04/08 18:06 |
| L5 | 30 | (dummy near3 gate with silici\$4) and source and drain and dish\$4 | US-PGPUB; USPAT; EPO; JPO; DERWENT | OR | OFF | 2006/04/08 16:55 |
| L6 | 2 | ("6686248").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/04/08 18:06 |
| L7 | 2 | ("6873051").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/04/08 18:07 |
| L8 | 2 | ("6797641").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/04/08 18:15 |
| L9 | 2 | ("6261883").PN. | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2006/04/08 18:15 |
| S1 | 2 | "257"/\$.ccls. and (dummy near silicide) same (gate) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | OFF | 2005/04/29 15:45 |